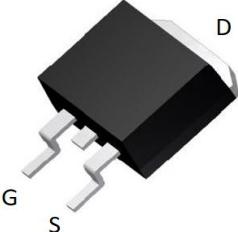


80V, 133A, 5.8mΩ N-channel Power SGT MOSFET

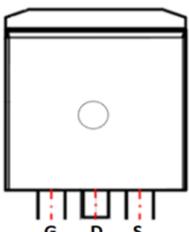
JBE083NS

| Features | Product Summary | | |
|--|---------------------------------|-------|------|
| • Excellent $R_{DS(ON)}$ and Low Gate Charge | Parameters | Value | Unit |
| • 100% UIS TESTED | V_{DSS} | 80 | V |
| • 100% ΔV_{ds} TESTED | $V_{GS(th)}_{Typ}$ | 3.0 | V |
| • Halogen-free; RoHS-compliant | $I_D(@V_{GS}=10V)$ | 133 | A |
| • Pb-free plating | $R_{DS(ON)}_{Typ}(@V_{GS}=10V)$ | 5.8 | mΩ |

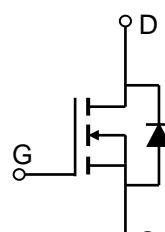
| Applications | RoHS | Pb |
|--------------------|---|---|
| • Load Switch |  |  |
| • PWM Application | | |
| • Power Management | | |



TO-263 -3L Top View



Pin Assignment



Schematic Diagram

Ordering Information

| Device | Marking | MSL | Form | Package | Reel(pcs) | Per Carton (pcs) |
|----------|---------|-----|-----------|-----------|-----------|------------------|
| JBE083NS | BE083NS | 3 | Tape&Reel | TO-263-3L | 800 | 4000 |

Absolute Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Value | Unit |
|----------------|---|---------------------------|-------|
| V_{DS} | Drain-to-Source Voltage | 80 | V |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| I_D | Continuous Drain Current | $T_C = 25^\circ\text{C}$ | 133 |
| | | $T_C = 100^\circ\text{C}$ | 94 |
| I_{DM} | Pulsed Drain Current ⁽¹⁾ | Refer to Fig.4 | A |
| E_{AS} | Single Pulsed Avalanche Energy ⁽²⁾ | 60 | mJ |
| P_D | Power Dissipation | $T_C = 25^\circ\text{C}$ | 252.2 |
| | | $T_C = 100^\circ\text{C}$ | 100.9 |
| T_J, T_{STG} | Junction & Storage Temperature Range | -55 to 150 | °C |

Thermal Characteristics

| Symbol | Parameter | Max | Unit |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient ⁽³⁾ | 35 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 0.5 | |



Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|--|------|------|-----------|------------------|
| Off Characteristics | | | | | | |
| $V_{(\text{BR})\text{DSS}}$ | Drain-Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ | 80 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 64\text{V}, V_{GS} = 0\text{V}$ | - | - | 1.0 | μA |
| I_{GSS} | Gate-Body Leakage Current | $V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$ | - | - | ± 100 | nA |
| On Characteristics | | | | | | |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ | 2.1 | 3.0 | 3.9 | V |
| $R_{\text{DS(ON)}}$ | Static Drain-Source ON-Resistance ⁽⁴⁾ | $V_{GS} = 10\text{V}, I_D = 20\text{A}$ | - | 5.8 | 7.5 | $\text{m}\Omega$ |
| Dynamic Characteristics | | | | | | |
| R_g | Gate Resistance | $f = 1\text{MHz}$ | - | 2.3 | - | Ω |
| C_{iss} | Input Capacitance | $V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, f = 1\text{MHz}$ | - | 2224 | - | pF |
| C_{oss} | Output Capacitance | | - | 1565 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 45 | - | pF |
| Q_g | Total Gate Charge | $V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 40\text{V}, I_D = 20\text{A}$ | - | 35 | - | nC |
| Q_{gs} | Gate Source Charge | | - | 12 | - | nC |
| Q_{gd} | Gate Drain("Miller") Charge | | - | 8 | - | nC |
| Switching Characteristics | | | | | | |
| $t_{d(\text{on})}$ | Turn-On Delay Time | $V_{GS} = 10\text{V}, V_{DD} = 40\text{V}$ $I_D = 20\text{A}, R_{\text{GEN}} = 6.2\Omega$ | - | 16 | - | ns |
| t_r | Turn-On Rise Time | | - | 32 | - | ns |
| $t_{d(\text{off})}$ | Turn-Off Delay Time | | - | 33 | - | ns |
| t_f | Turn-Off Fall Time | | - | 31 | - | ns |
| Body Diode Characteristics | | | | | | |
| I_S | Maximum Continuous Body Diode Forward Current | - | - | 133 | - | A |
| I_{SM} | Maximum Pulsed Body Diode Forward Current | - | - | 530 | - | A |
| V_{SD} | Body Diode Forward Voltage | $V_{GS} = 0\text{V}, I_S = 20\text{A}$ | - | | 1.2 | V |
| trr | Body Diode Reverse Recovery Time | $I_F = 20\text{A}, di/dt = 100\text{A/us}$ | - | 68 | - | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | | - | 111 | - | nC |

- Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
 2. E_{AS} condition: Starting $T_J=25^\circ\text{C}$, $V_{DD}=40\text{V}$, $V_G=10\text{V}$, $R_G=25\text{ohm}$, $L=3\text{mH}$, $I_{AS}=6.3\text{A}$, $V_{DD}=0\text{V}$ during time in avalanche.
 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.
 4. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 0.5\%$.



Typical Performance Characteristics

Figure 1: Power De-rating

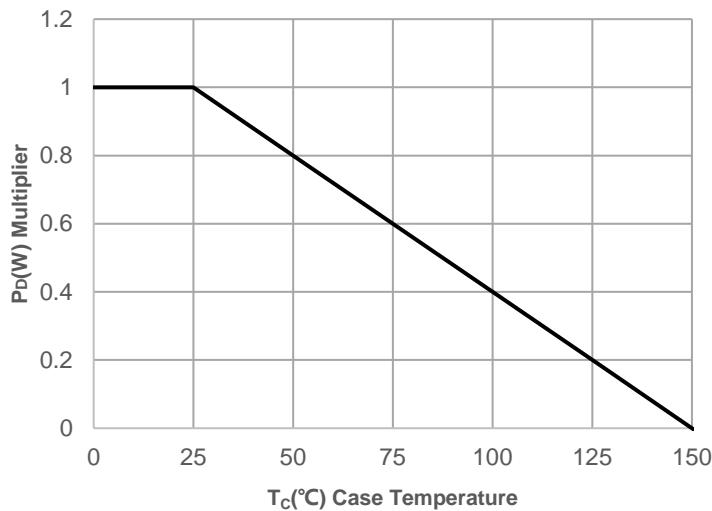


Figure 2: Current De-rating

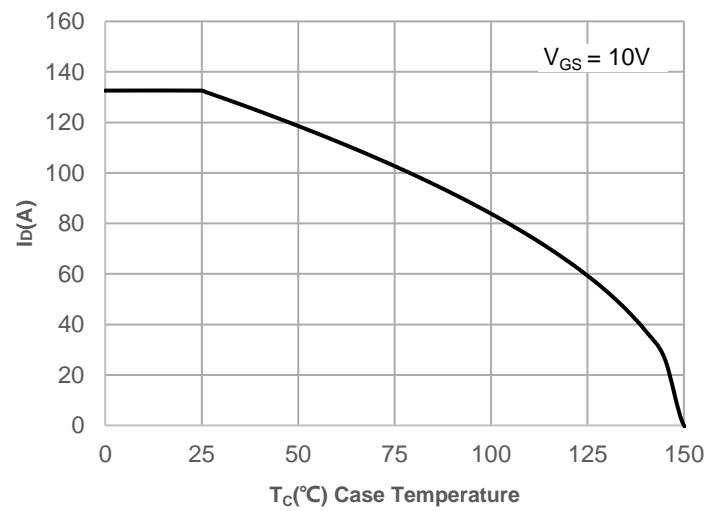


Figure 3: Normalized Maximum Transient Thermal Impedance

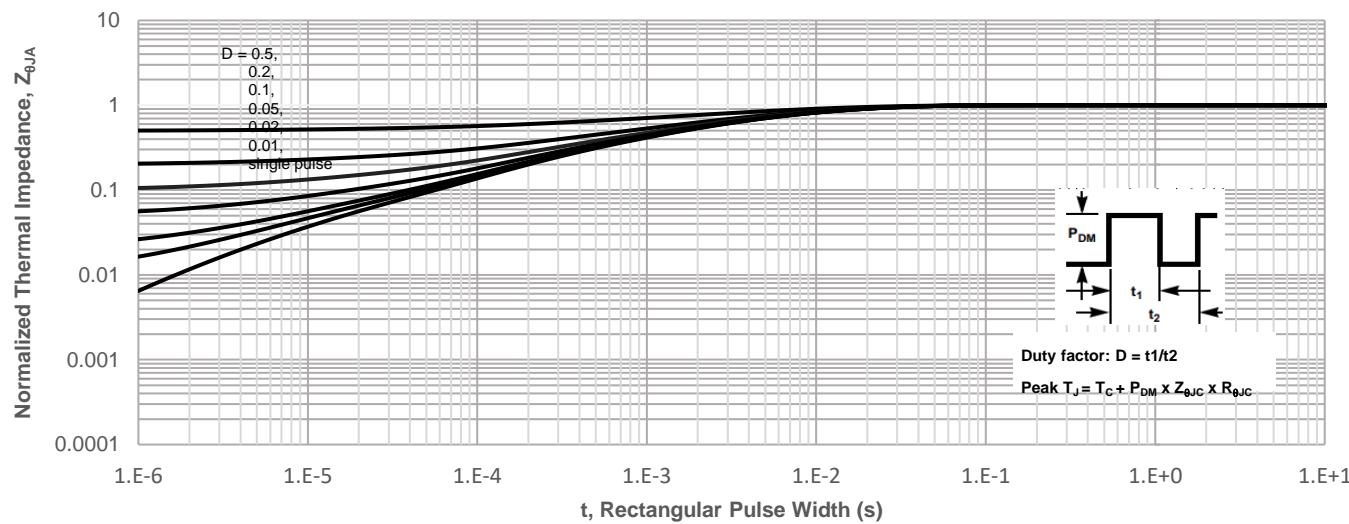


Figure 4: Peak Current Capacity



Typical Performance Characteristics

Figure 5: Output Characteristics

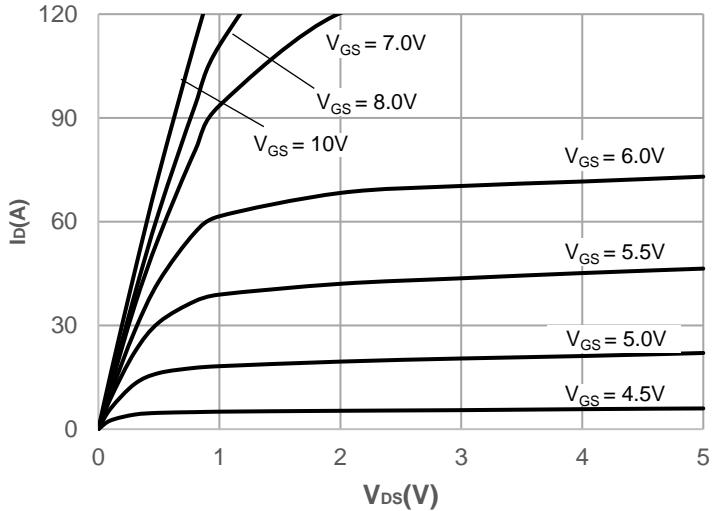


Figure 6: Typical Transfer Characteristics

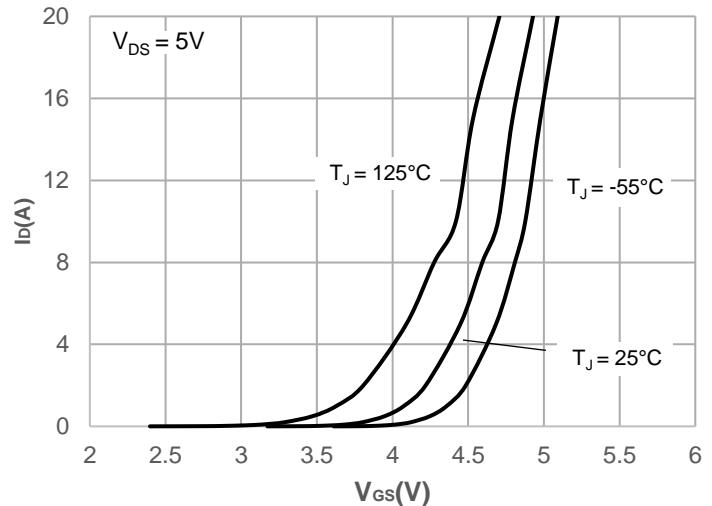


Figure 7: On-resistance vs. Drain Current

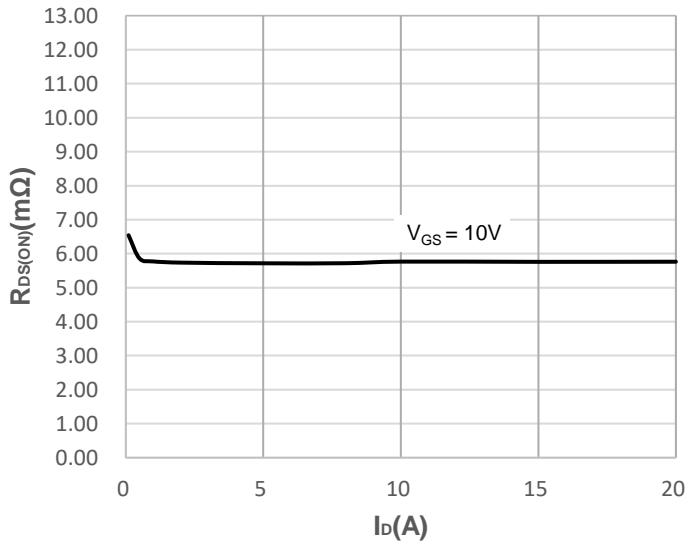


Figure 8: Body Diode Characteristics

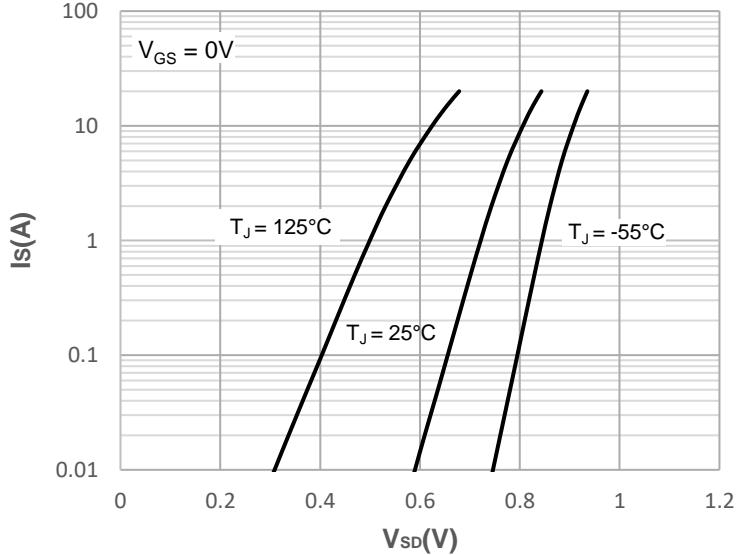


Figure 9: Gate Charge Characteristics

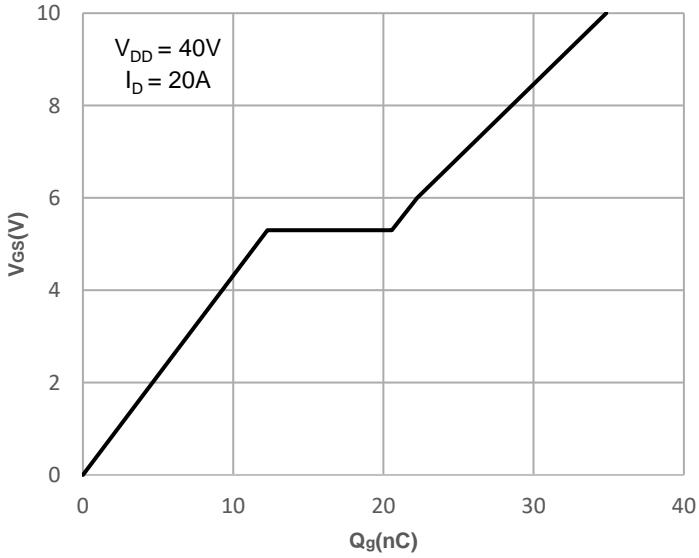
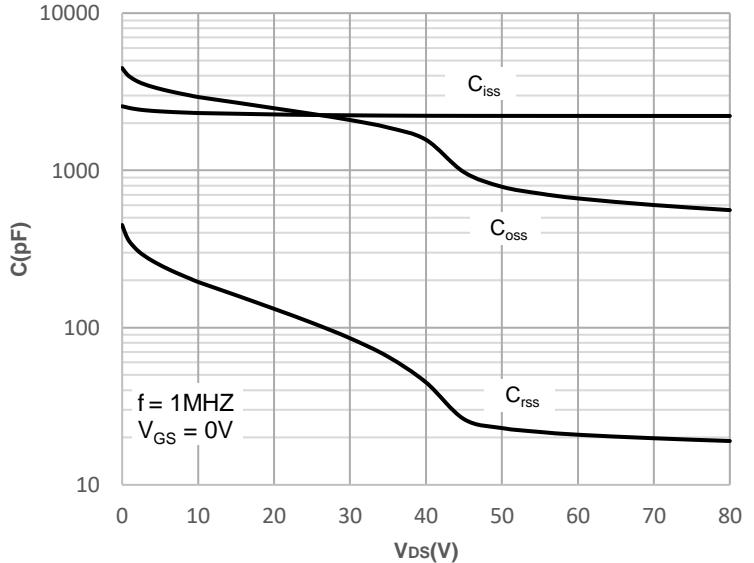


Figure 10: Capacitance Characteristics



Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

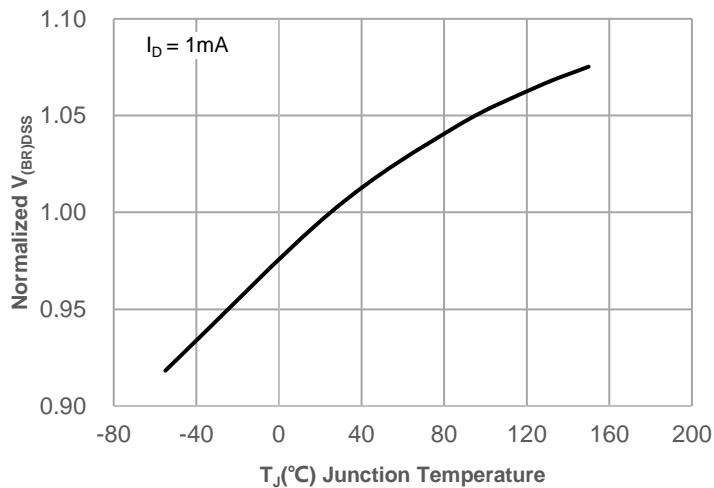


Figure 12: Normalized on Resistance vs. Junction Temperature

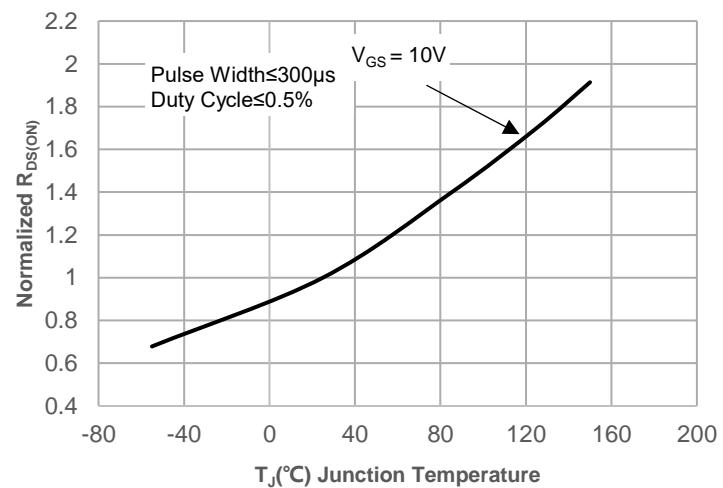


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

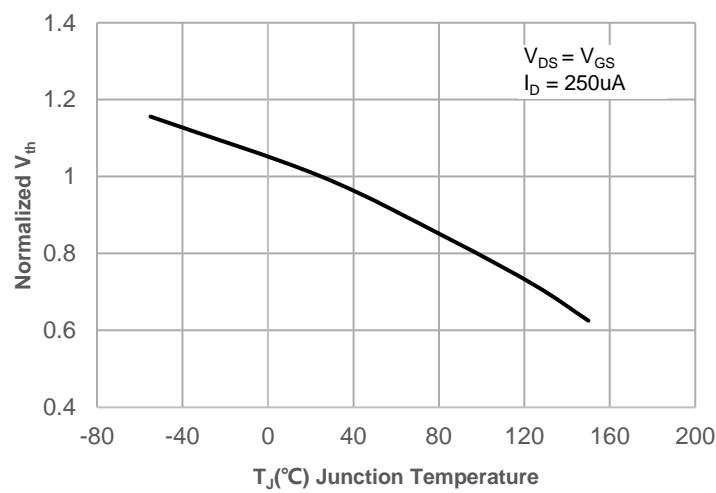


Figure 14: R_{DS(ON)} vs. V_{GS}

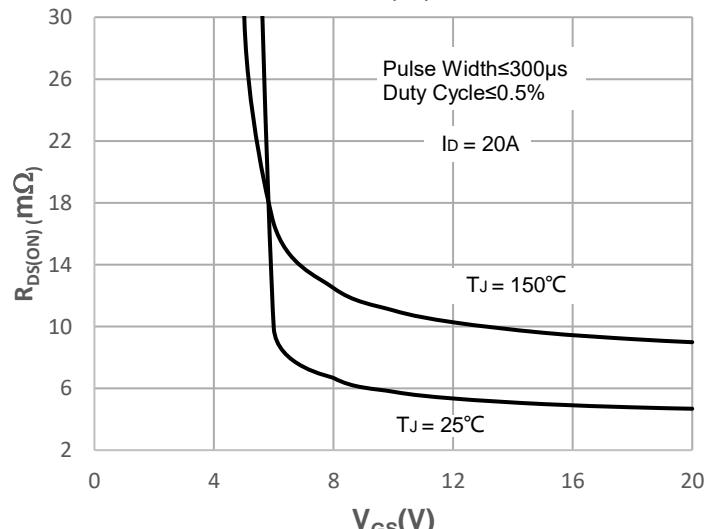
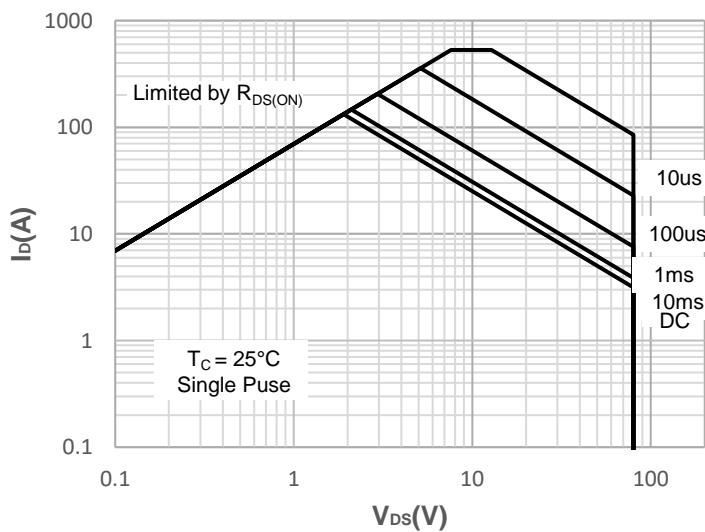


Figure 15: Maximum Safe Operating Area



Test Circuit

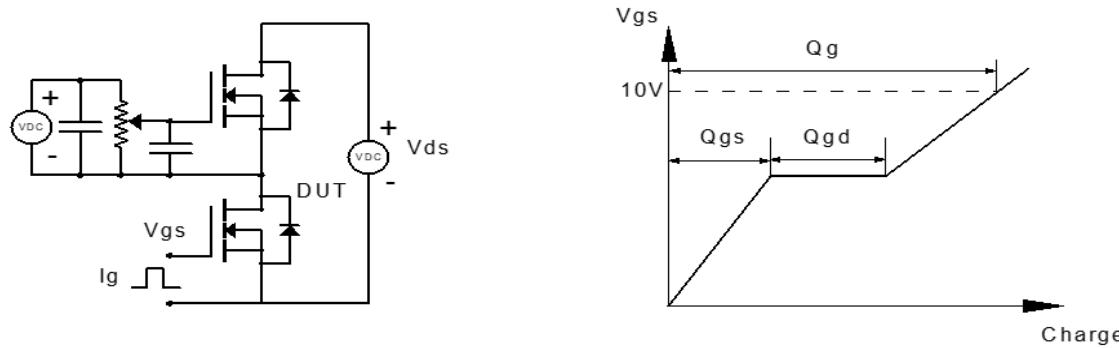


Figure 1: Gate Charge Test Circuit & Waveform

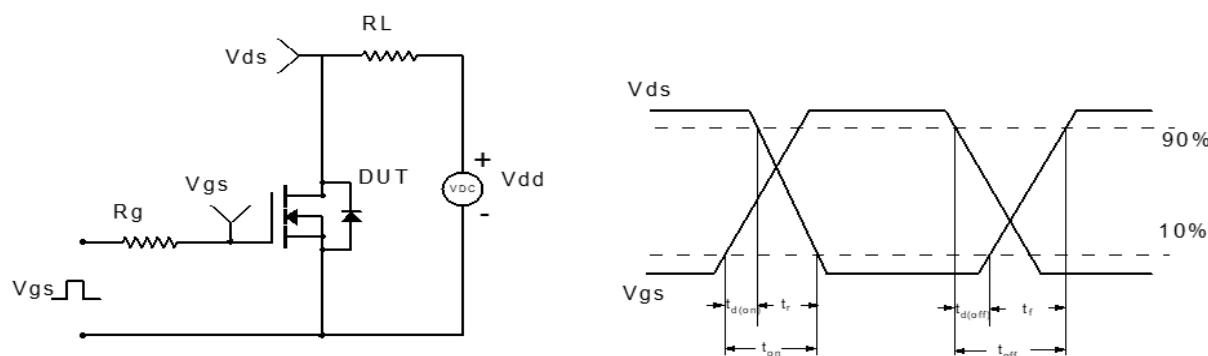


Figure 2: Resistive Switching Test Circuit & Waveform

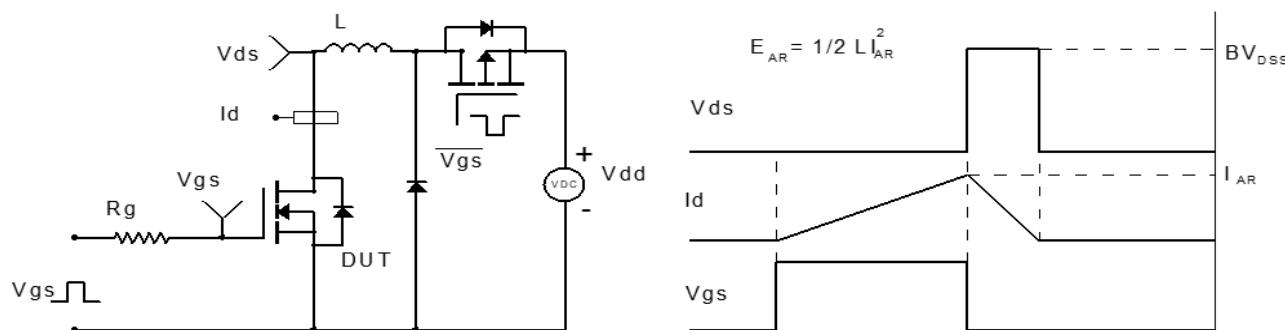


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

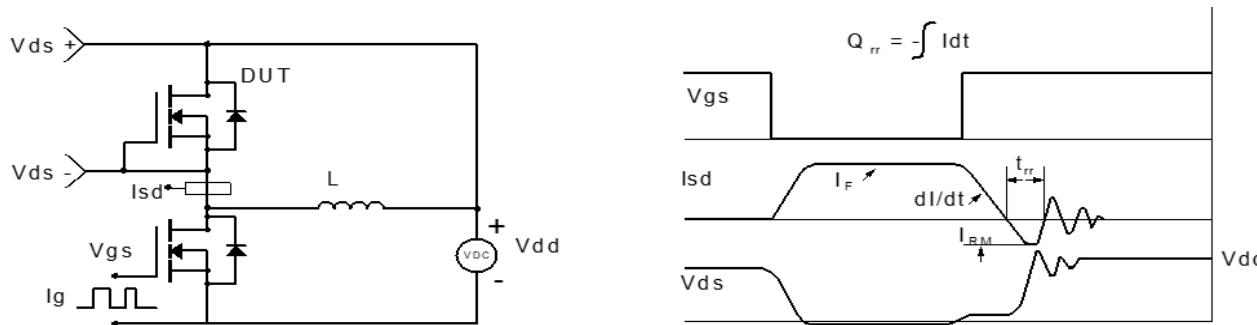
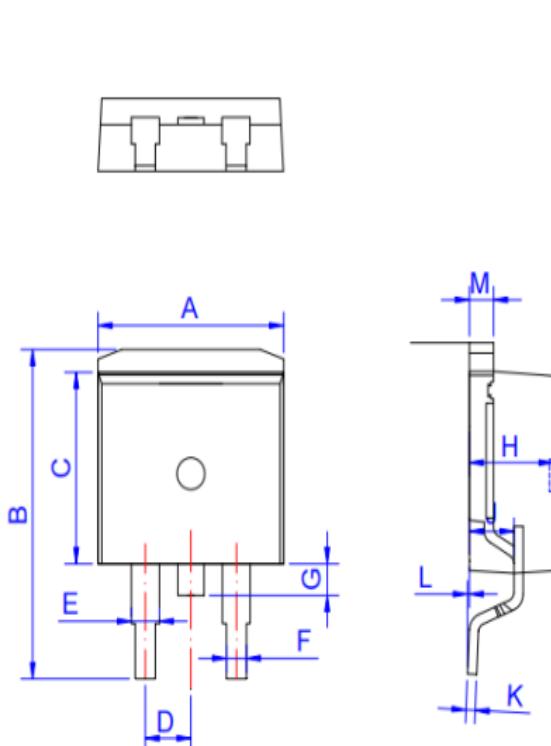


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-263 -3L)



| Ref. | Dimensions | | | | | |
|------|-------------|------|-------|--------|-------|-------|
| | Millimeters | | | Inches | | |
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 9.90 | | 10.20 | 0.390 | | 0.402 |
| B | 14.70 | | 15.80 | 0.579 | | 0.622 |
| C | 9.4 | | 9.6 | 0.37 | | 0.378 |
| D | | 2.54 | | | 0.100 | |
| E | 1.20 | | 1.40 | 0.047 | | 0.055 |
| F | 0.75 | | 0.85 | 0.029 | | 0.033 |
| G | | | 1.75 | | | 0.069 |
| H | 4.40 | | 4.70 | 0.173 | | 0.185 |
| J | 2.30 | | 2.70 | 0.091 | | 0.106 |
| K | 0.38 | | 0.55 | 0.015 | | 0.022 |
| L | 0 | 0.10 | 0.25 | 0 | 0.004 | 0.010 |
| M | 1.25 | | 1.35 | 0.049 | | 0.053 |

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